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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/535,029	WATANABE ET AL.	ANABE ET AL.
Examiner	Art Unit	nit
Marc S. Zimmer	1712	

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH (INCLUDING SEAR	NOTES CH STRATEG	<b>(</b> )
	DATE	EXMR
EAST (see attached)	2/12/2007	MZ
	2/13/2007	
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